

Search Notes

Application/Control No.

10/700,614

Examiner

Sing P. Chan

Applicant(s)/Patent under
Reexamination

KINNE ET AL.

Art Unit

1734

SEARCHED

| Class | Subclass | Date | Examiner |
|-------|-----------------------------------|-----------|----------|
| 156 | 71, 184, 191, 459, 523, 530 | 11/1/2005 | SPC |
| 156 | 574, 577 | 11/1/2005 | SPC |
| 156 | 579 | 11/1/2005 | SPC |
| 15 | 235.3 | 11/1/2005 | SPC |
| 15 | 235.4 | 11/1/2005 | SPC |
| 15 | 235.7 | 11/1/2005 | SPC |
| 425 | 458 | 11/1/2005 | SPC |
| | | | |
| | | | |
| | | | |
| | | | |
| | | | |
| | | | |
| | | | |
| | | | |

INTERFERENCE SEARCHED

| Class | Subclass | Date | Examiner |
|-------|----------|------|----------|
| | | | |
| | | | |
| | | | |
| | | | |

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

| | DATE | EXMR |
|--|-----------|------|
| Text and image search on EAST | 11/1/2005 | SPC |
| Inventors search on EAST and PALM on Daneil Kinne and Mark Steinhardt | 11/1/2005 | SPC |
| | | |
| | | |
| | | |
| | | |
| | | |
| | | |
| | | |
| | | |
| | | |